

**Search Notes**

Application/Control No.

10/625,792

Examiner

Patrick J. Lee

Applicant(s)/Patent under  
Reexamination

MANDRO ET AL.

Art Unit

2878

**SEARCHED**

Class	Subclass	Date	Examiner
250	221, 222.1, 231.1, 231.13	12/23/2005	PL
250	231.14	12/23/2005	PL
250	231.18	12/23/2005	PL
341	13, 141	12/23/2006	PL
Updated	search	5/30/2006	PL
Updated	search	9/21/2006	PL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (See attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	12/23/2005	PL
East (See attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	5/30/2006	PL
East (See attached) - USPAT, US- PGPUB, EPO, JPO, DERWENT	9/21/2006	PL